

June 2011

FDS89161

Dual N-Channel PowerTrench[®] MOSFET 100 V, 2.7 A, 105 m Ω

Features

- Max $r_{DS(on)}$ = 105 m Ω at V_{GS} = 10 V, I_D = 2.7 A
- Max $r_{DS(on)}$ = 171 m Ω at V_{GS} = 6 V, I_D = 2.1 A
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability in a widely used surface mount package
- 100% UIL Tested
- RoHS Compliant

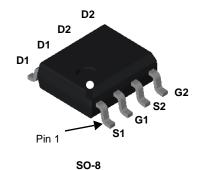


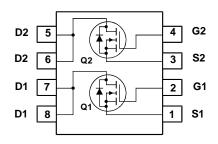
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been optimized for $r_{DS(on)}$, switching performance and ruggedness.

Applications

- Synchronous Rectifier
- Primary Switch For Bridge Topology





MOSFET Maximum Ratings T_A = 25 ℃ unless otherwise noted

| Symbol | Parar | meter | | Ratings | Units |
|-----------------------------------|--------------------------------------|-----------------------|----------|-------------|-------|
| V _{DS} | Drain to Source Voltage | | | 100 | V |
| V_{GS} | Gate to Source Voltage | | | ±20 | V |
| | Drain Current -Continuous | | | 2.7 | ^ |
| ID | -Pulsed | | | 15 | Α |
| E _{AS} | Single Pulse Avalanche Energy | | (Note 3) | 13 | mJ |
| В | Power Dissipation | T _C = 25 ℃ | | 31 | W |
| P_{D} | Power Dissipation | T _A = 25 ℃ | (Note1a) | 1.6 | VV |
| T _J , T _{STG} | Operating and Storage Junction Tempe | rature Range | | -55 to +150 | C |

Thermal Characteristics

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | (Note 1) | 4.0 | €/W |
|-----------------|---|-----------|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 78 | C/VV |

Package Marking and Ordering Information

| Device Marking | Device | Package Reel Size | | Tape Width | Quantity | |
|----------------|----------|-------------------|------------|------------|------------|--|
| FDS89161 | FDS89161 | SO-8 | 13 " 12 mn | | 2500 units | |

Electrical Characteristics $T_J = 25$ $^{\circ}$ C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|--|--|---|-----|-----|------|-------|
| Off Chara | cteristics | | | | | |
| BV_{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 100 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = 250 μA, referenced to 25 °C | | 67 | | mV/℃ |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 80 V, V _{GS} = 0 V | | | 1 | μΑ |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±100 | nA |

On Characteristics

| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ | 2 | 3 | 4 | V |
|----------------------------------|--|--|---|-----|-----|------|
| $\Delta V_{GS(th)}$ ΔT_J | Gate to Source Threshold Voltage Temperature Coefficient | I_D = 250 μA, referenced to 25 °C | | -9 | | mV/℃ |
| | | $V_{GS} = 10 \text{ V}, I_D = 2.7 \text{ A}$ | | 86 | 105 | |
| r _{DS(on)} | Static Drain to Source On Resistance | $V_{GS} = 6 \text{ V}, I_D = 2.1 \text{ A}$ | | 120 | 171 | mΩ |
| | | $V_{GS} = 10 \text{ V}, I_D = 2.7 \text{ A}, T_J = 125 ^{\circ}\text{C}$ | | 144 | 176 | |
| 9 _{FS} | Forward Transconductance | $V_{DS} = 10 \text{ V}, I_D = 2.7 \text{ A}$ | | 5 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V 50.V.V 0.V | 158 | 210 | pF |
|------------------|------------------------------|---|-----|-----|----|
| Coss | Output Capacitance | $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz | 43 | 58 | pF |
| C _{rss} | Reverse Transfer Capacitance | T = TIVILIZ | 3 | 5 | pF |
| R_{α} | Gate Resistance | | 1 | | Ω |

Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | | | | 4.2 | 10 | ns |
|---------------------|-------------------------------|--|--|--|-----|-----|----|
| t _r | Rise Time | $V_{DD} = 50 \text{ V}, I_D = 2.7$ | $V_{DD} = 50 \text{ V}, I_{D} = 2.7 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | | 1.3 | 10 | ns |
| t _{d(off)} | Turn-Off Delay Time | V _{GS} = 10 V, R _{GEN} : | | | 7.3 | 15 | ns |
| t _f | Fall Time | | | | 1.9 | 10 | ns |
| $Q_{g(TOT)}$ | Total Gate Charge | V _{GS} = 0 V to 10 V | | | 3 | 4.1 | nC |
| $Q_{g(TOT)}$ | Total Gate Charge | $V_{GS} = 0 V to 5 V$ | $V_{DD} = 50 \text{ V},$ | | 1.7 | 2.4 | |
| Q_{gs} | Gate to Source Charge | | $I_D = 2.7 \text{ A}$ | | 0.8 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | | | 0.8 | | nC |

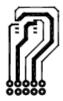
Drain-Source Diode Characteristics

| V | V _{SD} Source to Drain Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = 2.7 \text{ A}$ | (Note 2) | 0.85 | 1.3 | \/ |
|---------------------------------------|---|---|----------|------|-----|----|
| Source to Drain Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = 2 \text{ A}$ | (Note 2) | 0.82 | 1.2 | V | |
| t _{rr} | Reverse Recovery Time | - I _F = 2.7 A, di/dt = 100 A/μs | | 34 | 54 | ns |
| Q _{rr} | Reverse Recovery Charge | | | 21 | 34 | nC |

^{1.} R_{BJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a) 78℃/W when mounted on a 1 in² pad of 2 oz copper



b) 135℃/W when mounted on a minimun pad

- 2. Pulse Test: Pulse Width < 300 μs , Duty cycle < 2.0%. 3. Starting T $_J$ = 25°C, $\,L$ = 3 mH, I $_{AS}$ = 3 A, V $_{DD}$ = 100 V, V $_{GS}$ = 10 V.

Typical Characteristics (N-Channel) T_J = 25°C unless otherwise noted

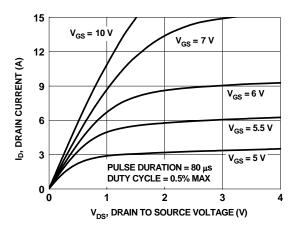


Figure 1. On-Region Characteristics

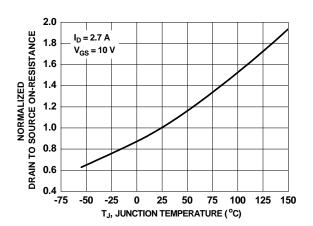


Figure 3. Normalized On-Resistance vs Junction Temperature

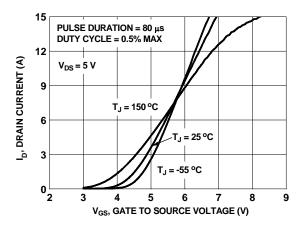


Figure 5. Transfer Characteristics

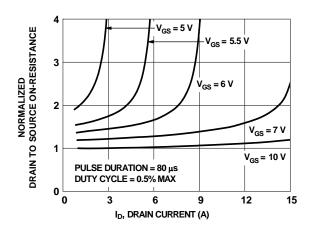


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

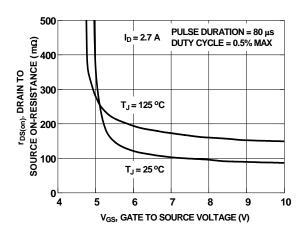


Figure 4. On-Resistance vs Gate to Source Voltage

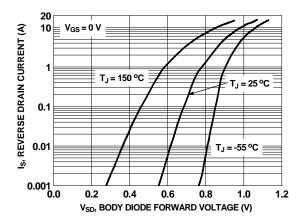


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (N-Channel) T_J = 25°C unless otherwise noted

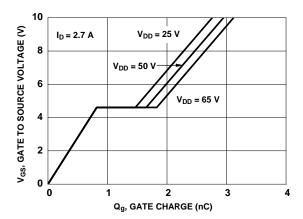


Figure 7. Gate Charge Characteristics

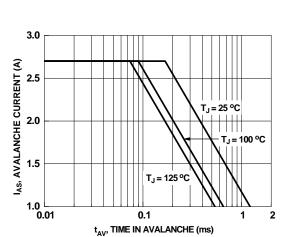


Figure 9. Unclamped Inductive Switching Capability

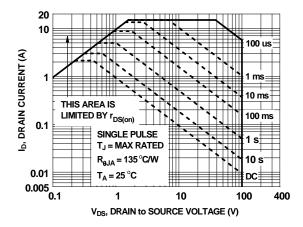


Figure 11. Forward Bias Safe Operating Area

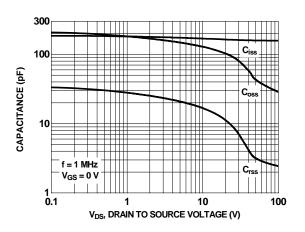


Figure 8. Capacitance vs Drain to Source Voltage

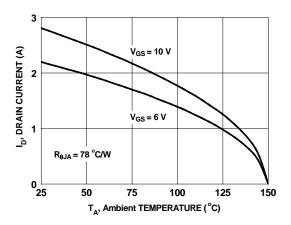


Figure 10. Maximum Continuous Drain Current vs Ambient Temperature

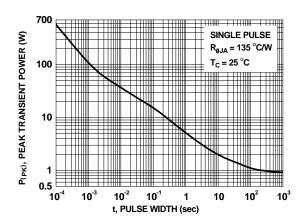


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics (N-Channel) $T_J = 25$ °C unless otherwise noted

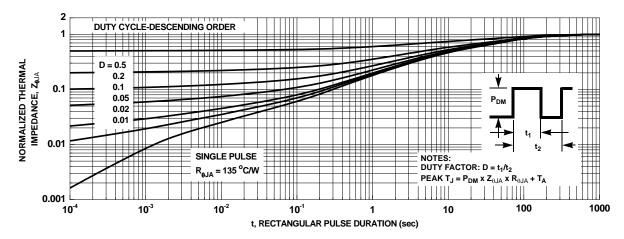


Figure 13. Junction-to-Ambient Transient Thermal Response Curve





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